

N-Channel MOSFET

General Description

The WSD6036DN33 is the highest performance trench N-Channel MOSFET with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The WSD6036DN33 meet the RoHS and Green Product requirement 100% E_{AS} guaranteed with full function reliability approved.

Features

- Lead Free and Green Devices Available (RoHS Compliant)
- 100% UIS + Rg Tested
- Reliable and Rugged
- Moisture Sensitivity Level MSL1 (per JEDEC J-STD-020D)

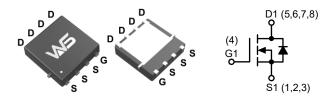
Product Summery

BV _{DSS}	R _{DS(ON)}	I _D		
60V	14mΩ	50A		

Applications

- Secondary Side Synchronous Rectification
- DC-DC Converter
- Motor Control
- Load Switching

DFN3X3-8L Pin Configuration



Absolute Maximum Ratings (T_A=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rating	Units	
V _{DS}	Drain-Source Voltage		60	\/	
V _{GS}	Gate-Source Voltage		±20	V	
,	Continuous Drain Current	T _C =25°C	50		
l _D		T _C =100°C	30	A	
I _{DM} ¹	Pulsed Drain Current	T _C =25°C	90		
P _D	Maximum Power Dissipation	T _C =25°C	45	W	
		T _C =100°C	18	VV	
E _{AS} ³	Single Pulse Avalanche Energy	L=0.1mH	39.2	mJ	
I _S	Diode Continuous Forward Current	T _C =25°C	50	А	
T _{STG}	Storage Temperature Range		-55 to 150	°C	
T_J	Operating Junction Temperature Range		150		

Thermal Data

Symbol	Parameter		Тур.	Max.	Units
R _{0JA} ²	Thermal Resistance Junction to ambient	Steady State		62	°C/W
$R_{ heta JC}$	Thermal Resistance-Junction to Case	Steady State		3.3	C/VV



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Electrical Characteristics (T_A=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units	
Static	Static						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250μA	60			V	
	V_{DS} =30V , V_{GS} =0V	V _{DS} =30V , V _{GS} =0V			1.0	μA	
I _{DSS}	Zero Gate Voltage Drain Current	T _J =85°C			30		
I _{GSS}	Gate Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA	
On Characte	ristics						
V _{GS(th)}	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_{DS}=250\mu A$	1.0	1.6	2.5	V	
D 4	D : 0 0 11 D : 1	V _{GS} =10V , I _D =25A		14	17.5	· mΩ	
R _{DS(ON)} ⁴	Drain-Source On-state Resistance	V _{GS} =4.5V , I _D =20A		19	22		
Switching	•		•	•			
Q_g	Total Gate Charge			42		nC	
Q _{gs}	Gate-Source Charge	V _{DS} =30V , V _{GS} =10V , I _D =25A		6.4			
Q_{gd}	Gate-Drain Charge			9.6			
T _{d(on)}	Turn-on Delay Time			17		ns	
T _r	Turn-on Rise Time	V _{GEN} =10V , V _{DD} =30V , I _D =1A		9			
T _{d(off)}	Turn-off Delay Time	$R_G=6\Omega$, $R_L=30\Omega$		58			
T _f	Turn-on Fall Time			14			
R _g	Gat resistance	V _{GS} =0V , V _{DS} =0V , f = 1.0MHz		1.5		Ω	
Dynamic							
C _{iss}	Input Capacitance			2100			
C _{oss}	Output Capacitance	V _{GS} =0V , V _{DS} =30V , f = 1.0MHz		140		pF	
C _{rss}	Reverse Transfer Capacitance	-		100			
Drain-Source Diode Characteristics and Maximum Ratings							
I _S	Continuous Source Current	V V 2V 5			18		
I _{SM}	Pulsed Source Curren ³	V _G =V _D =0V , Force Current			35	A	
V _{SD} ⁴	Diode Forward Voltage	I _{SD} =20A , V _{GS} =0V		0.8	1.3	V	
t _{rr}	Reverse Recovery Time	1 -05A dl /dt-100A/v-		27		ns	
Q _{rr}	Reverse Recovery Charge	- I _{DS} =25A,dI _{SD} /dt=100A/μs		33		nC	

Note:

- 1. Pulse width limited by max. junction temperature.
- 2. Surface Mounted on 1in² pad area.
- 3. UIS tested and pulse width limited by maximum junction temperature 150°C(initial temperature $T_J=25$ °C).
- 4. Pulse test ; pulse width≤300µs, duty cycle≤2%.
- 5. Guaranteed by design, not subject to production testing.



Typical Characteristics

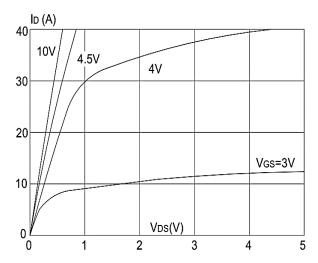


Figure1: Output Characteristics

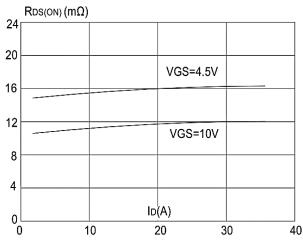


Figure 3:On-resistance vs. Drain Current

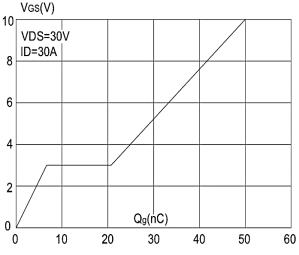


Figure 5: Gate Charge Characteristics

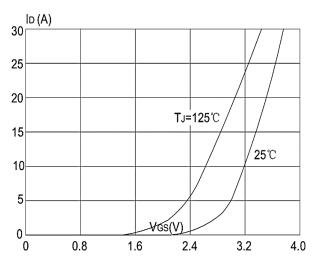


Figure 2: Typical Transfer Characteristics

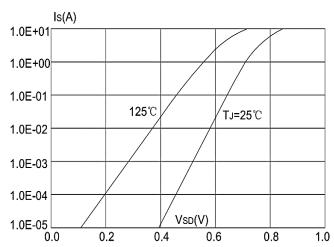


Figure 4: Body Diode Characteristics

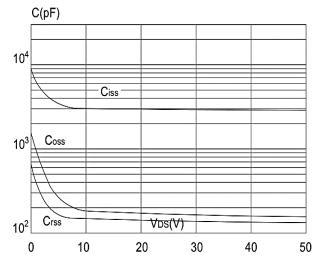


Figure 6: Capacitance Characteristics



Typical Characteristics (Cont.)

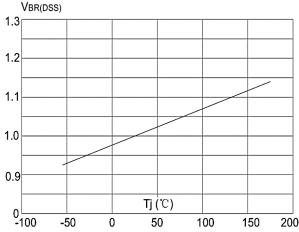


Figure 7: Normalized Breakdown Voltage vs Junction Temperature

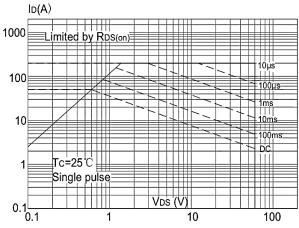


Figure 9: Maximum Safe Operating Area

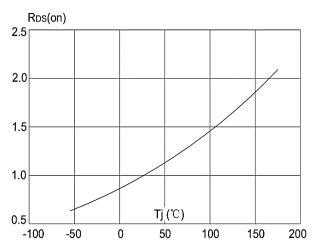


Figure 8: Normalized on Resistance vs.

Junction Temperature

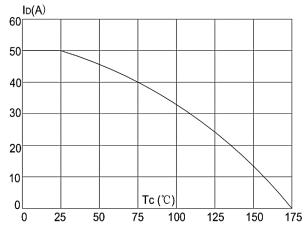


Figure 10: Maximum Continuous Drain Current vs. Ambient Temperature

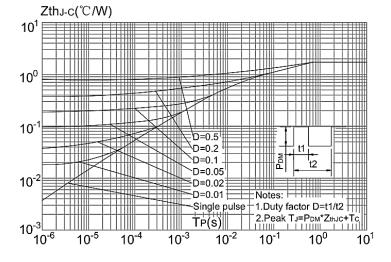
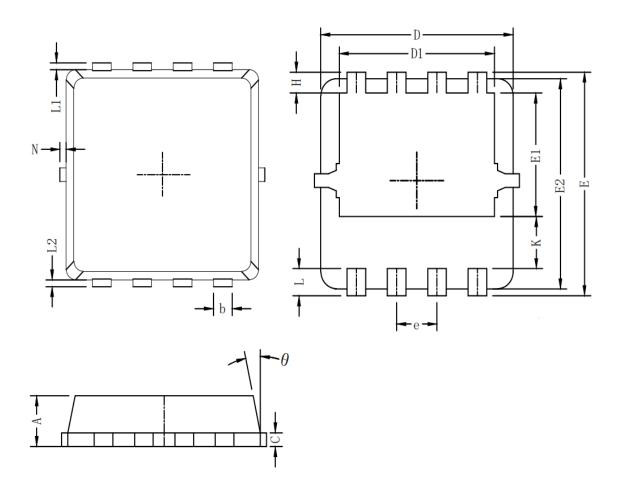


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Ambien



Packaging information



Symbol	Dim in mm			
	min	typ	max	
А	0.6	0.75	0.9	
b	0.2	0.3	0.4	
С	0.15	0.2	0.25	
D	3	3.1	3.2	
D1	2.3	2.45	2.6	
E	3.15	3.3	3.45	
E1	1.43	1.73	1.93	
E2	2.9	3.05	3.2	
е	0.65BSC			
Н	0.2	0.35	0.5	
K	0.57	0.77	0.87	
L	0.3	0.4	0.5	
L1/L2	0.1REF			
θ	8°	10°	13°	
N	0		0.15	



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